Dkt. 05166

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

PCT

ALBRECHT MAURER et al

Serial No. 10/564,737

Filed: January 19, 2006

For: METHOD AND CIRCUIT ARRANGEMENT FOR DISTURBANCE-FREE EXAMINATION OF OBJECTS BY MEANS OF ULTRASONIC WAVES

## INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

Applicants submit herewith a Form PTO-1449 listing references cited in the corresponding PCT and German applications, together with copies of non-U.S. patent references.

Respectfully submitted,

Ira J. Schultz

Registration No. 28666

ALEXANDRIA, VIRGINIA 22314-2700

DENNISON, SCHULTZ, DOUGHERTY & MACDONALD

LAW OFFICES

•		(3	API	R 1	2 20	9 06 //	) [5]	05/2	20/2008 She	et _	<u>1</u> of	_1	
Form					DEMAR CLOS	SUE	PE.	CITATION	05166	Appln. No. 10/564,737			
1111		N A							APPLICAMT Maurer et al				
	(Use	seve	ral :	she	ets i	f ne	cess	ary)	January 19, 2006	GROUP.			
		_	_	_			_	U.S. PA	TENT DOCUMENTS				
EXAMI NER INITI AL	DOCUMENT NUMBER DATE							DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		NG DATE PROPRIATE
	6	0	2	3	6	6	0	02/2000	Dory				
	<u> </u>	Ш	Ш	Ц		П				<u> </u>		<u> </u>	
		$\vdash$	$\vdash$	Н		Н	_			ļ			
		$\vdash$	$\vdash$	Н		Н	_			-	-	<del> </del> —	
		Н	Н	Н	—	H	-			├	1		
		Н	$\sqcap$	$\neg$		Н	$\dashv$			<del>                                     </del>			
		$\vdash$	П			П					$\vdash$		
		<u>—</u>		_		_	_	FOREIGN	PATENT DOCUMENTS				
											SUB	TRAF	NSLATION
	DOCUMENT NUMBER						┙	DATE	COUNTRY	CLASS	SUB CLASS	YES	NO
	3	2	3	6	0	1	7	03/1984	DE				
	92/	0	9	5	8	1	-	01/1992	WO WO				
	007	H	-	_	٥	H	-	11/2002	WO				
		Н	$\dashv$	$\Box$		1				I	1 1		
				'	7	П				<del>                                     </del>	$\vdash$		
		ш	Ш	_	OTHE	RI	)OC	UMENTS (Includ	ling Author, Title, Date, Pertinent Page	etc.)			
		E115,	pern No.	n,	Syn	the	tio		ing Author, Title, Date, Pertinent Pages Focusing Technique for In		staura	tion,	, Vol.
		5, Mal	No.	n, . (	Syn 8, j	the pp.	tic 2- pti	Aperture I -6, 2000.		mage Re			
		5, Mai Ari Mai	No. haut rays	n, . ( t, s,	Syn: 08, p An i Ult: Dev	the pp. Ada ras	tic 2- pti oni	c Aperture I -6, 2000. ive System ics, IPC Scient of Phase	Focusing Technique for In	mage Re tions ( 8.	Using E	Phased	d
		Mah Ari Mah Uli	No. haut rays haut tras	t, s, to	An Deve	the pp. Ada ras elo , I	pti oni pme PC	Aperture I -6, 2000. ive System i ics, IPC Sci ent of Phase Sci. Etc.,	Focusing Technique for In for Advanced NDT Applicat i. Etc., pp 128-131, 1990 ed Array Techniques to In	mage Re tions ( 8. mprove.	Using E	Phased netry,	d,
		Mah Ari Mah Uli Cas 463	No. haut rays haut tras sser 1-46	t, s, sor rea 64,	Synthesis Synthe	the pp. Ada ras elo , I The 00.	ptioni pme PC Ph	c Aperture 1 -6, 2000. ive System 1 ics, IPC Scient of Phase Sci. Etc., nased Array	Focusing Technique for Information Informa	tions (8. mprove.	Using E	hased netry,	d , pp
		Mah Ari Mah Uli Cas 463	No. haut rays haut tras sser 1-46	t, s, sor rea 64,	Synthesis Synthe	the pp. Ada ras elo , I The 00.	ptioni pme PC Ph	c Aperture in the control of the control of Phase Sci. Etc., nased Array	Focusing Technique for Information Translation (Information Information Info	tions (8. mprove.	Using E	hased netry,	d , pp
EXAMINE		Mah Arri Mah Ult Cas 46:	No. haut rays haut tras sser 1-46 y, C	t, s, t, sor rea 64,	Synthesis Synthe	the pp. Ada ras elo , I The 00.	ptioni pme PC Pr	c Aperture in the control of the control of Phase Sci. Etc., nased Array	Focusing Technique for Information Translation of Police Information	tions (8. mprove.	Using E	hased netry,	d , pp

OIPE